


<b>Search Notes</b>  	<b>Application/Control No.</b>  10678846	<b>Applicant(s)/Patent Under Reexamination</b>  BOWMAN ET AL.
	<b>Examiner</b>  Kiss, Eric B	<b>Art Unit</b>  2192

### SEARCHED

Class	Subclass	Date	Examiner
717	109, 113, 115	09/28/2009	EBK
715	744, 760, 762	09/28/2009	EBK

### SEARCH NOTES

Search Notes	Date	Examiner
PALM Inventor search	08/28/2007	EBK
EAST (USPAT; US-PGPUB; FPRS; EPO; JPO; DERWENT; IBM_TDB) (see search history printout)	08/28/2007	EBK
Updated EAST search (see search history printout)	09/28/2009	EBK

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference searched (USPAT, UPAD; txt search; see search history printout)	09/28/2009	EBK

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